

RESCUE EDA Toolset for interdependent aspects of reliability, security and quality in nanoelectronic systems design
Gürsoy, Cemil Cem; Cardoso Medeiros, Guilherme; Chen, Juanho; **Balakrishnan, Aneesh;** Lai, Xinhui; Bagbaba, Ahmet Cagri;
Raik, Jaan; Jenihhin, Maksim DATE 2019 2019 / 1 p. : ill <https://doi.org/10.5281/zenodo.3362529> <https://past.date-conference.com/>

RESCUE: interdependent challenges of reliability, security and quality in nanoelectronic systems

Jenihhin, Maksim; Raik, Jaan 2020 Design, Automation & Test in Europe Conference & Exhibition (DATE), 9-13 March 2020, Grenoble, France : proceedings 2020 / art. 19690741 , 6 p <https://doi.org/10.23919/DATE48585.2020.9116558>

Resynthesis-based attacks against logic locking

Almeida, Felipe; Aksoy, Levent; Nguyen, Quang-Linh; Dupuis, Sophie; Flottes, Marie-Lise; **Pagliarini, Samuel Nascimento** 2023 24th International Symposium on Quality Electronic Design (ISQED) : San Francisco, 5-7 April 2023 2023 / 8 p. : ill <https://doi.org/10.1109/ISQED57927.2023.10129403> [Article at Scopus](#) [Article at WOS](#)